

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/657,339	CREUSOT ET AL.		
Examiner	Art Unit		
Y Lee	2621		

SEARCHED					
Class	Subclass	Date	Examiner		
375	240.01 240.12 240.25 240.28	6/5/2007	YL		
H04N	7/12				
update	search	8/1/2007	YL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
No. 1				
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